(12) INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

(19) World Intellectual Property Organization

International Bureau





(43) International Publication Date 16 December 2004 (16.12.2004)

PCT

(10) International Publication Number WO 2004/109261 A1

(51) International Patent Classification7:

G01N 21/27

(21) International Application Number:

PCT/US2004/017340

(22) International Filing Date:

3 June 2004 (03.06.2004)

(25) Filing Language:

English

(26) Publication Language:

English

(30) Priority Data:

60/475,288

3 June 2003 (03.06.2003)

10/821,441 9 April 2004 (09.04.2004)

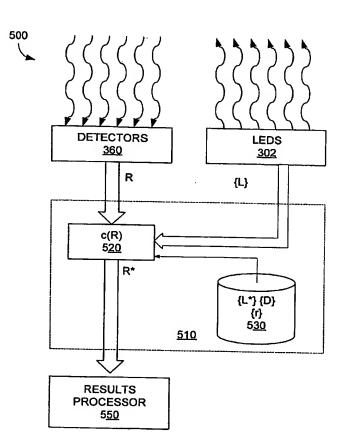
- (71) Applicant (for all designated States except US): BAYER HEALTHCARE, LLC [US/US]; 333 Coney Street, East Walpole, MA 02032 (US).
- (72) Inventor; and
- (75) Inventor/Applicant (for US only): HOWARD, Willis,

E., III [US/US]; 2720 E. Jackson Boulevard, Elkhart, IN 46516 (US).

- (74) Agents: KUSMER, Toby, H. et al.; McDermott, Will & Emery LLP, 28 State Street, Boston, MA 02109 (US).
- (81) Designated States (unless otherwise indicated, for every kind of national protection available): AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BW, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, EG, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NA, NI, NO, NZ, OM, PG, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, SY, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM,
- (84) Designated States (unless otherwise indicated, for every kind of regional protection available): ARIPO (BW, GH, GM, KE, LS, MW, MZ, NA, SD, SL, SZ, TZ, UG, ZM, ZW), Eurasian (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM),

[Continued on next page]

(54) Title: LIGHT SOURCE WAVELENGTH CORRECTION



(57) Abstract: A wavelength correction function provides corrected reflectance values from actual reflectance values taken in a reflectance-base instrument. The correction is provided as a function of measured reflectance values and a predefined set of high resolution reflectance values established for the reflectance-based instrument implementing the wavelength correction function.

WO 2004/109261 A1

WO 2004/109261 A1

European (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HU, IE, IT, LU, MC, NL, PL, PT, RO, SE, SI, SK, TR), OAPI (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, ML, MR, NE, SN, TD, TG).

 before the expiration of the time limit for amending the claims and to be republished in the eyent of receipt of amendments

Published:

with international search report

For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.